

FDW258P

P-Channel 1.8V Specified PowerTrench® MOSFET

General Description

This P-Channel 1.8V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (1.8V-8V).

Applications

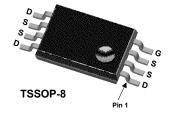
- · Load switch
- Motor drive
- DC/DC conversion
- · Power management

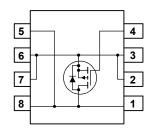
Features

• -9 A, -12 V. $R_{DS(ON)}$ = 11 m Ω @ V_{GS} = -4.5 V $R_{DS(ON)}$ = 14 m Ω @ V_{GS} = -2.5 V

 $R_{DS(ON)} = 20 \text{ m}\Omega \text{ @ } V_{GS} = -1.8 \text{ V}$

- Rds ratings for use with 1.8 V logic
- · Low gate charge
- High performance trench technology for extremely low R_{DS(ON)}
- Low profile TSSOP-8 package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		-12	V
V_{GSS}	Gate-Source Voltage		±8	V
I _D	Drain Current - Continuous	(Note 1)	- 9	Α
	Pulsed		-50	
P _D	Power Dissipation	(Note 1a)	1.3	W
		(Note 1b)	0.6	
T_J , T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	87	°C/W
		(Note 1b)	114	

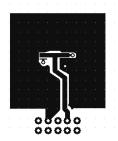
Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
258P FDW258P		13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		l	l		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-12			V
ΔBV _{DSS} ΔT, _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-3		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μА
I _{GSSF}	Gate–Body Leakage, Forward	$V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = -8 \text{ V}.$ $V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-0.6	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$\begin{aligned} &V_{GS} = -4.5 \text{ V}, & I_D = -9 \text{ A} \\ &V_{GS} = -2.5 \text{ V}, & I_D = -8 \text{ A} \\ &V_{GS} = -1.8 \text{ V}, & I_D = -6.5 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, &I_D = -9 \text{ A}, &I_J = 125^\circ \end{aligned}$		8.6 10.6 13.8 11.2	11 14 20 14	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-50			Α
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -9 \text{ A}$		50		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -5 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		5049		pF
Coss	Output Capacitance	f = 1.0 MHz		1943		pF
C _{rss}	Reverse Transfer Capacitance			1226		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -6 \text{ V}, \qquad I_D = -1 \text{ A},$		17	31	ns
t _r	Turn-On Rise Time	V_{GS} = -4.5 V, R_{GEN} = 6 Ω		23	37	ns
t _{d(off)}	Turn-Off Delay Time			201	322	ns
t _f	Turn-Off Fall Time	7		148	237	ns
Qg	Total Gate Charge	$V_{DS} = -6 \text{ V}, \qquad I_{D} = -9 \text{ A},$		61	73	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		8		nC
Q_{gd}	Gate-Drain Charge	<u> </u>		16		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source	<u> </u>			-1.25	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.25 \text{ A (Note 2)}$		-0.6	-1.2	V

Notes

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a) 87°C/W when mounted on a 1in² pad of 2 oz copper.



o) 114°C/W when mounted on a minimum pad of 2 oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

Typical Characteristics

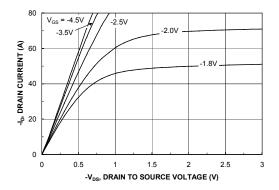


Figure 1. On-Region Characteristics.

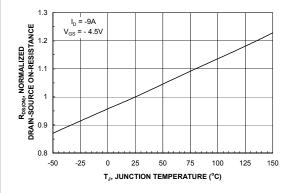


Figure 3. On-Resistance Variation with Temperature.

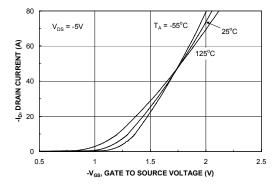


Figure 5. Transfer Characteristics.

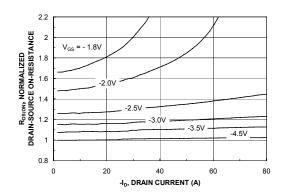


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

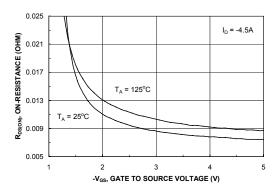


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

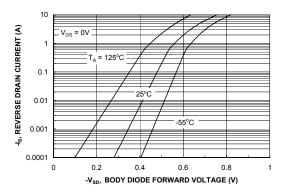
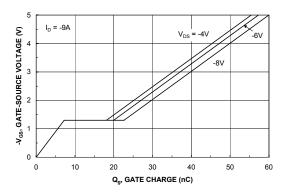


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



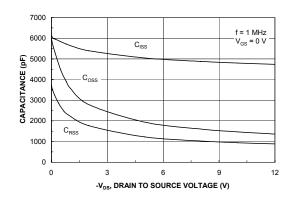
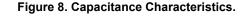
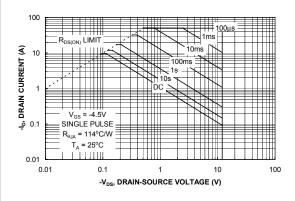


Figure 7. Gate Charge Characteristics.





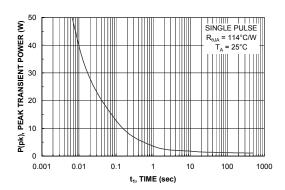


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

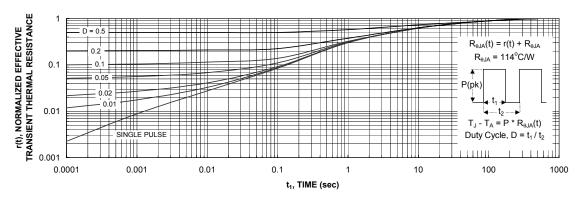


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.





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